

EMC Testing of the
Manufacturer: Blues Inc.
Starnote for Iridium
In accordance with FCC 47 CFR Part 15B



Prepared for: Blues Inc.
50 Harbor Street
Manchester, Massachusetts 01944 USA

COMMERCIAL-IN-CONFIDENCE

721021685-02 Issue 01

RESPONSIBLE FOR	NAME	DATE	SIGNATURE
Authorized Signatory	Ferdinand Custodio	16 September 2026	

Signatures in this approval box have checked this document in line with the requirements of TÜV SÜD Product Service document control rules.

EXECUTIVE SUMMARY

A sample of this product was tested and found to be in compliance with FCC 47 CFR Part 15B.

The logo for ILAC-MRA, featuring a circular design with the text "ilac-MRA" inside.	The logo for A2LA Accredited, featuring the letters "A2LA" in a stylized font with the word "ACCREDITED" below it.	DISCLAIMER AND COPYRIGHT This non-binding report has been prepared by TÜV SÜD America with all reasonable skill and care. The document is confidential to the potential Client and TÜV SÜD America. No part of this document may be reproduced without the prior written approval of TÜV SÜD America. © 2019 TÜV SÜD America.
A2LA Cert. No. 2955.13	ACCREDITATION	Our A2LA Accreditation does not cover opinions and interpretations and any expressed are outside the scope of our A2LA Accreditation.

TÜV SÜD America, Inc.
10040 Mesa Rim Road
San Diego, CA 92121-2912

TÜV SÜD America, Inc.
Rancho Bernardo Facility
16936 Via Del Campo
San Diego, CA 92127

Phone: 858 678 1400
www.tuv-sud-america.com



Contents

1.1	Report Modification Record.....	2
1.2	Introduction.....	2
1.3	Brief Summary of Results	3
1.4	Product Information	4
1.5	Deviations from the Standard.....	6
1.6	EUT Modification Record	6
1.7	Test Location	6
2	Test Details	8
2.1	Conducted Disturbance at Mains Terminals	8
2.2	Radiated Disturbance	13
3	Test Equipment Information	22
3.1	General Test Equipment Used.....	22
4	Incident Reports	23
5	Photographs	24
5.1	Equipment Under Test (EUT).....	24
6	Measurement Uncertainty	25



Report Summary

1.1 Report Modification Record

Alterations and additions to this report will be issued to the holders of each copy in the form of a complete document.

Issue	Description of Change	Date of Issue
1	First Issue	09/16/2026

Table 1

1.2 Introduction

Applicant	Blues Inc.
Manufacturer	Blues Inc.
Model Number(s)	Starnote for Iridium
Serial Number(s)	1A010K
Number of Samples Tested	1
Test Specification/Issue/Date	FCC 47 CFR Part 15B
Test Plan/Issue/Date	N/A
Order Number	200210025265
Date	June 1 st 2026
Date of Receipt of EUT	June 10 th 2026
Start of Test	July 09 th 2026
Finish of Test	July 09 th 2026
Name of Engineer(s)	Miguel Angel Rabago Garcia (MARG)
Related Document(s)	ANSI C63.4 2014ANSI 63.4: 2014



Product Service

1.3 Brief Summary of Results

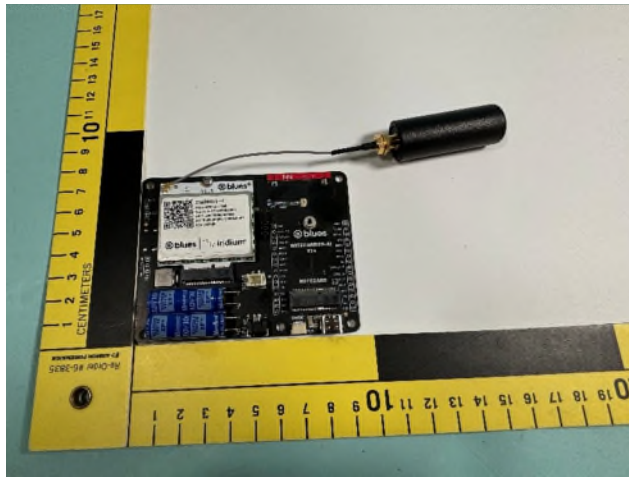
A brief summary of the tests carried out in accordance with FCC 47 CFR Part 15B is shown below.

Section	Specification Clause	Test Description	Result	Comments/Base Standard
Battery Powered--Idle Mode				
2.1	15.107	Conducted Disturbance at Mains Terminals	Pass	ANSI C63.4 2014
2.2	15.109	Radiated Disturbance	Pass	ANSI 63.4: 2014

Table 2

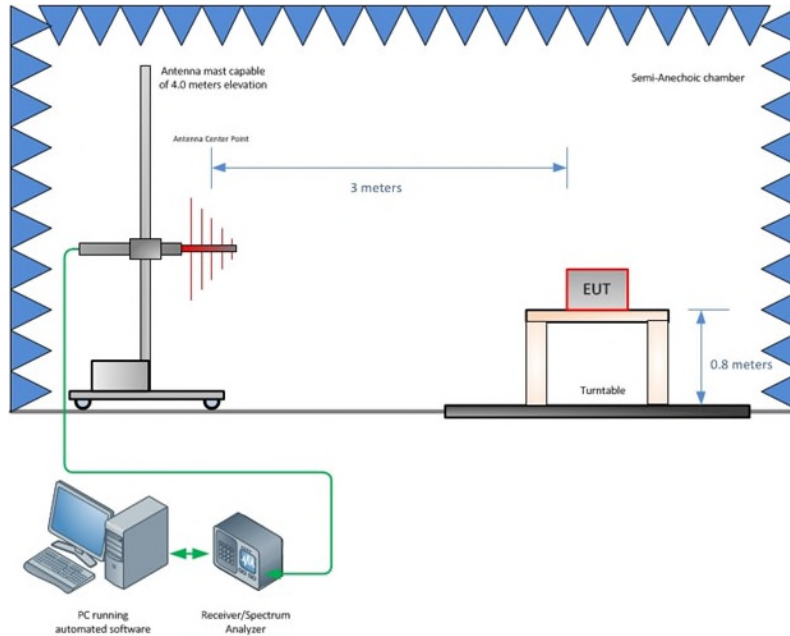
1.4 Product Information

The Equipment Under Test (EUT) was a companion system-on-Module card for Notecard that add pre-certified satellite connectivity to other connected products.

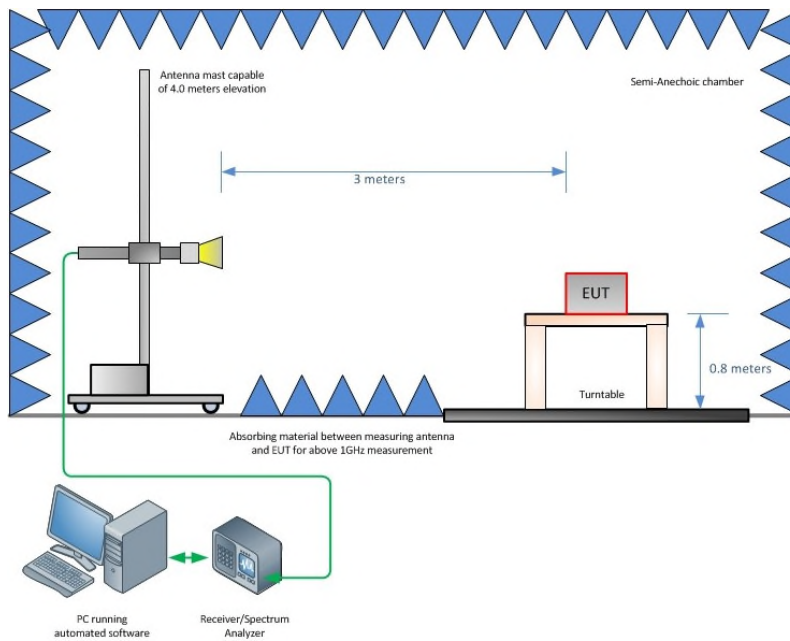


Equipment Under Test.

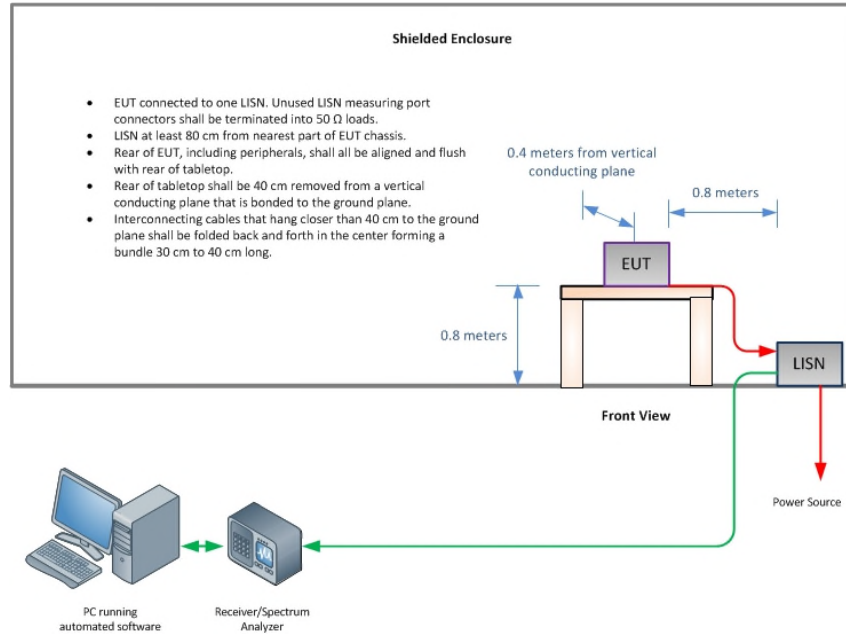
1.4.1 Test Configuration



Radiated Disturbance Below 1 GHz Test Diagram



Radiated Disturbance Above 1 GHz Test Diagram



Conducted Disturbance Test Diagram

1.4.2 Modes of Operation

Mode	Description
Idle	The EUT was idle mode (EUT Was powered On but it was not transmitting)

1.5 Deviations from the Standard

No deviations from the applicable test standard were made during testing.

1.6 EUT Modification Record

The table below details modifications made to the EUT during the test program. The modifications incorporated during each test are recorded on the appropriate test pages.

Modification State	Description of Modification still fitted to EUT	Modification Fitted By	Date Modification Fitted
0	As supplied by the customer	Not Applicable	Not Applicable

Table 3

1.7 Test Location

TÜV SÜD conducted the following tests at our San Diego Test Laboratory.



Product Service

Test Name	Name of Engineer(s)	Accreditation
Configuration and Mode: Idle Mode – Starnote for Iridium		
Radiated Disturbance	Miguel Angel Rabago Garcia	A2LA
Conducted Disturbance at AC mains terminals	Miguel Angel Rabago Garcia	A2LA

Table 4

Laboratory Address: 10040 Mesa Rim Rd
San Diego CA, 92121 USA





2 Test Details

2.1 Conducted Disturbance at Mains Terminals

2.1.1 Specification Reference

FCC 47 CFR Part 15B, Clause 15.107

2.1.2 Equipment Under Test and Modification State

Serial Number: 1A010K / MARG

2.1.3 Date of Test

July 09 2026

2.1.4 Test Method

Idle Mode

The EUT was placed on a non-conductive table 0.8m above a reference ground plane. All power was connected to the EUT through a 2-line V Network. Conducted disturbance voltage measurements on mains lines were made at the output of the 2-line V Network. The 2-line V Network was placed 0.8m from the boundary of the EUT and bonded to the reference ground plane.

2.1.5 Environmental Conditions

Ambient Temperature	25.4°C
Relative Humidity	39%

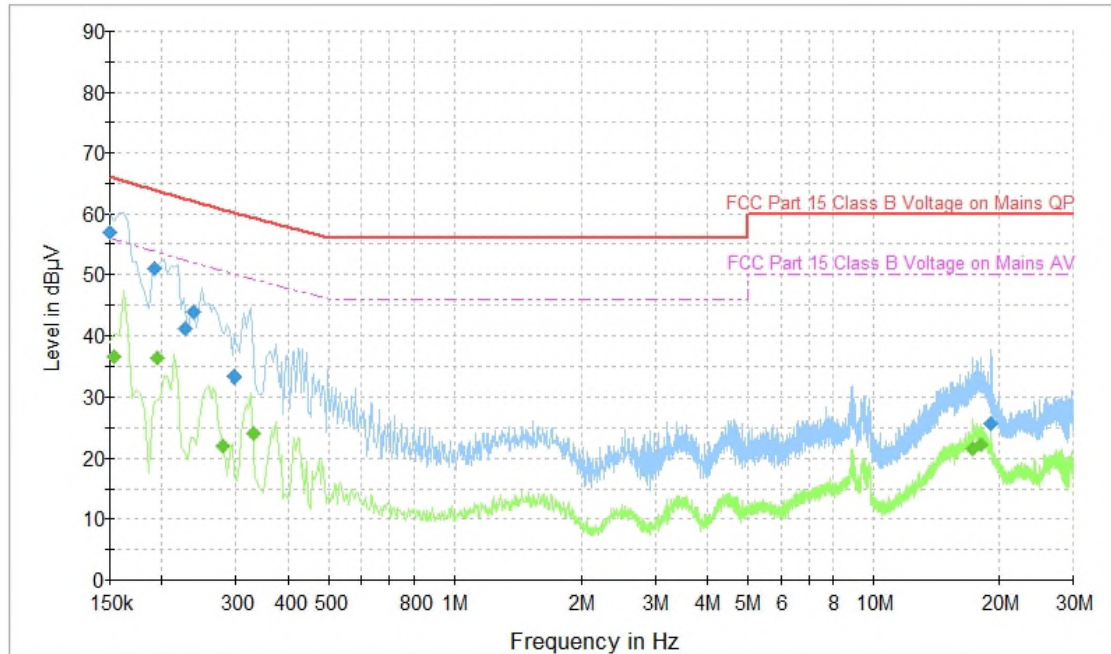
2.1.6 Test Results

Results for Configuration and Mode: Idle Mode.

Performance assessment of the EUT made during this test: **Pass.**

Detailed results are shown below.

2.1.7 FCC Part 15 B Class B Line 1



Preview Result 2-AVG [Preview Result 2.Result:2]
 Preview Result 1-PK+ [Preview Result 1.Result:1]
 FCC Part 15 Class B Voltage on Mains QP [..EMI Conducted]
 FCC Part 15 Class B Voltage on Mains AV [..EMI Conducted]
 Final_Result QPK [Final_Result.Result:4]
 Final_Result AVG [Final_Result.Result:5]

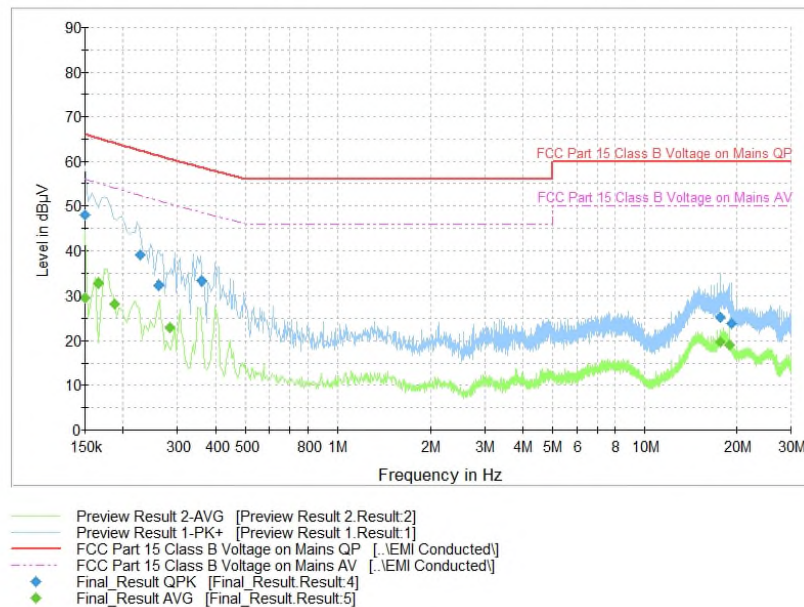
Final Results QPK

Frequency (MHz)	QuasiPeak (dBµV)	Limit (dBµV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Filter	Corr. (dB)	Sig Path (dB)	Trd Corr. (dB)
0.150000	57.03	66.00	8.97	1000.0	9.000	L1	OFF	9.6	0.150000	57.03
0.191500	51.08	63.84	12.76	1000.0	9.000	L1	OFF	9.6	0.191500	51.08
0.226500	40.99	62.39	21.40	1000.0	9.000	L1	OFF	9.6	0.226500	40.99
0.238500	43.75	61.95	18.20	1000.0	9.000	L1	OFF	9.6	0.238500	43.75
0.298000	33.23	60.10	26.86	1000.0	9.000	L1	OFF	9.6	0.298000	33.23
19.077000	25.60	60.00	34.40	1000.0	9.000	L1	OFF	10.0	19.077000	25.60

Final Results AVG

Frequency (MHz)	QuasiPeak (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Filter	Corr. (dB)	Sig Path (dB)	Trd Corr. (dB)
0.154000	36.57	55.76	19.19	1000.0	9.000	L1	OFF	9.6	0.154000	36.57
0.195500	36.18	53.63	17.45	1000.0	9.000	L1	OFF	9.6	0.195500	36.18
0.279500	21.97	50.59	28.61	1000.0	9.000	L1	OFF	9.6	0.279500	21.97
0.331500	24.20	49.20	24.99	1000.0	9.000	L1	OFF	9.6	0.331500	24.20
17.279500	21.60	50.00	28.40	1000.0	9.000	L1	OFF	10.0	17.279500	21.60
18.039500	22.31	50.00	27.69	1000.0	9.000	L1	OFF	10.0	18.039500	22.31

2.1.8 FCC Part 15 B Class B Line 2



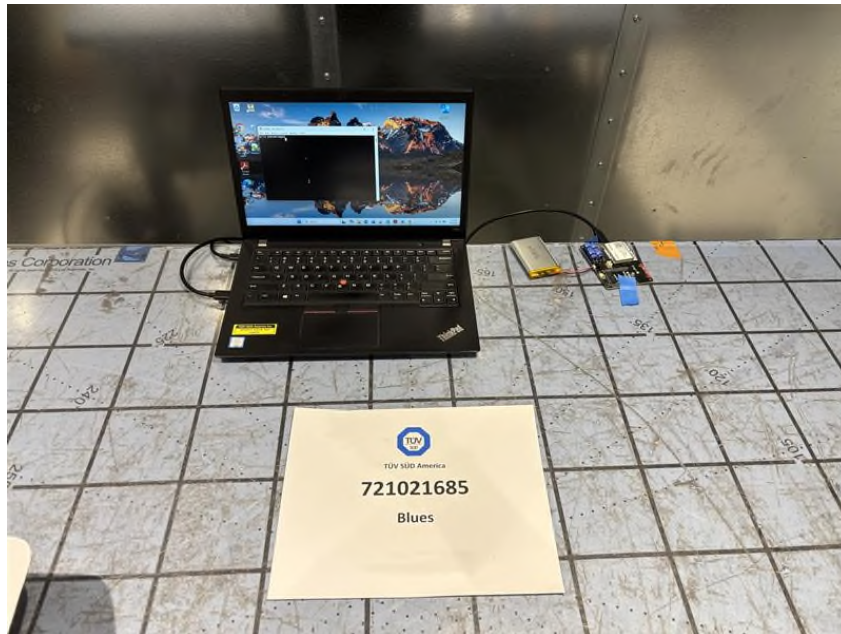
Final Results QPK

Frequency (MHz)	QuasiPeak (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Filter	Corr. (dB)	Sig Path (dB)	Trd Corr. (dB)
0.150000	47.98	66.00	18.02	1000.0	9.000	N	OFF	9.6	0.150000	47.98
0.226500	38.95	62.39	23.45	1000.0	9.000	N	OFF	9.6	0.226500	38.95
0.261500	32.39	61.18	28.79	1000.0	9.000	N	OFF	9.6	0.261500	32.39
0.360500	33.40	58.56	25.16	1000.0	9.000	N	OFF	9.6	0.360500	33.40
17.616000	25.17	60.00	34.83	1000.0	9.000	N	OFF	10.2	17.616000	25.17
19.151500	23.94	60.00	36.06	1000.0	9.000	N	OFF	10.2	19.151500	23.94

Final Results AVG

Frequency (MHz)	QuasiPeak (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Filter	Corr. (dB)	Sig Path (dB)	Trd Corr. (dB)
0.150000	29.51	56.00	26.49	1000.0	9.000	N	OFF	9.6	0.150000	29.51
0.166000	32.74	55.08	22.34	1000.0	9.000	N	OFF	9.6	0.166000	32.74
0.187500	28.21	54.00	25.79	1000.0	9.000	N	OFF	9.6	0.187500	28.21
0.283500	23.01	50.47	27.46	1000.0	9.000	N	OFF	9.6	0.283500	23.01
17.635500	19.81	50.00	30.19	1000.0	9.000	N	OFF	10.2	17.635500	19.81
18.871500	19.13	50.00	30.87	1000.0	9.000	N	OFF	10.2	18.871500	19.13

2.1.9 Test Setup photos





2.1.10 Test Location and Test Equipment Used

This test was carried out in the Mira Mesa Facility (SR5).

Instrument	Manufacturer	Type No	TE No	Calibration Period (months)	Calibration Due
Two-Line Network	Rohde & Schwarz	ENV-216	65161	12	07/24/2026
EMI Test Receiver	Rohde & Schwarz	ESU40	SDGE07620	12	08/08/2026

Table 5



2.2 Radiated Disturbance

2.2.1 Specification Reference

FCC 47 CFR Part 15B, Clause 15.109

2.2.2 Test Limits

FCC 47 CFR Part 15B, Limit Clause 15.109

Frequency (MHz)	Field Strength ($\mu\text{V/m}$)	Measurement Distance (m)
30 to 88	100	3
88 to 216	150	3
216 to 960	200	3
Above 960	500	3

2.2.3 Equipment Under Test and Modification State

Serial Number: 1A010K /MARG

2.2.4 Date of Test

July 09 2026

2.2.5 Test Method

idle Mode

The EUT was set up in a semi-anechoic chamber on a remotely controlled turntable and placed on a nonconductive table 0.8m above a reference ground plane

A prescan of the EUT emissions profile was made while varying the antenna to the EUT azimuth and antenna to the EUT polarization using a peak detector; measurements were taken at a 3m distance. Using the prescan list of the highest emissions detected, their bearing and associated antenna polarization, the EUT was then formally measured using a Quasi-Peak detector. The readings were maximized by adjusting the antenna height, polarization and turntable azimuth, in accordance with the specification.

2.2.6 Environmental Conditions

Ambient Temperature 25.4°C
Relative Humidity 39%

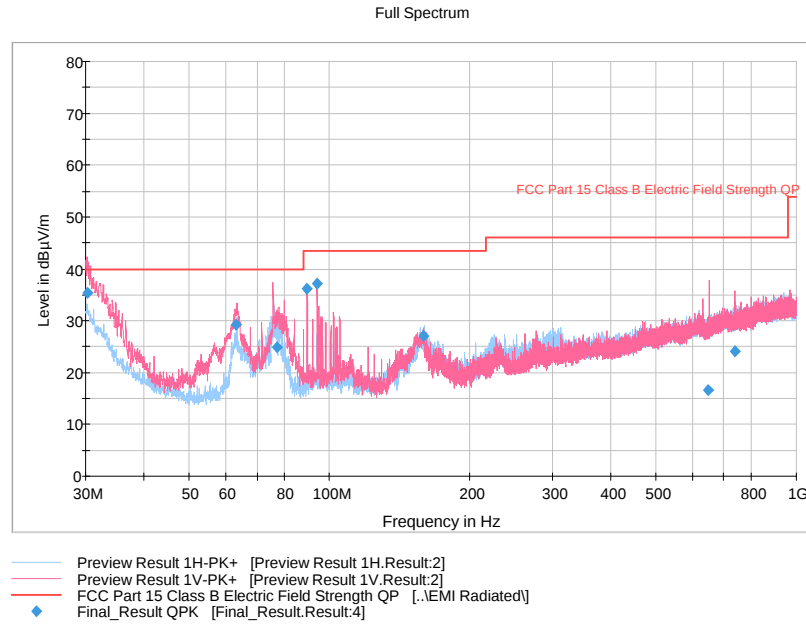
2.2.7 Test Results

Results for Configuration and Mode: Battery Powered and Charging Mode-Idle Mode.

Performance assessment of the EUT made during this test: **Pass.**

Highest frequency generated or used within the EUT: 1625.97915073MHz
Which necessitates an upper frequency test limit of: 18GHz

2.2.8 FCC Part 15 B Class B Idle Mode 30MHz to 1GHz Results



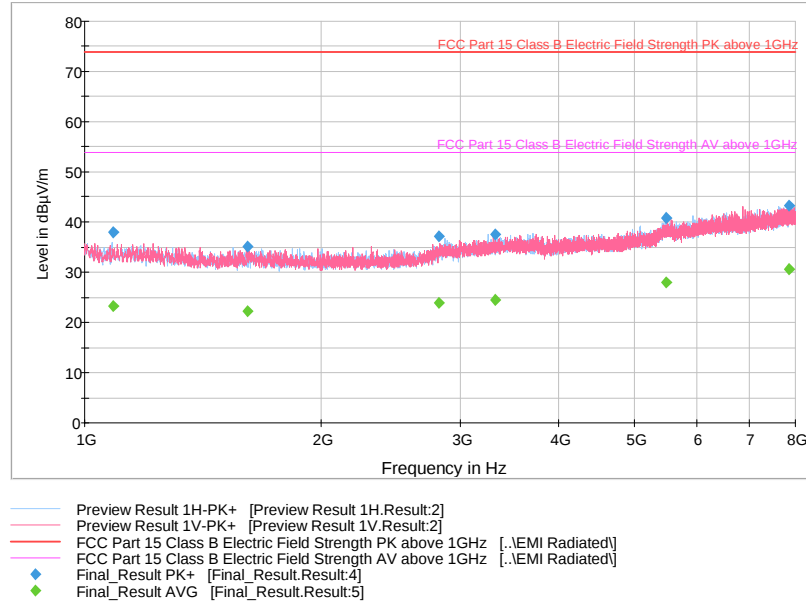
RSE 30MHz-1GHz

30MHz to 1GHz Test Data

Frequency (MHz)	Level (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
30.320000	35.42	40.00	4.58	1000.0	1000.000	102.0	H	270.0	-14
62.937333	29.26	40.00	10.74	1000.0	1000.000	102.0	H	270.0	-14
77.231667	24.95	40.00	15.05	1000.0	1000.000	350.0	V	29.0	-15
89.493333	36.17	43.50	7.33	1000.0	1000.000	350.0	V	29.0	-15
94.109333	37.05	43.50	6.45	1000.0	1000.000	102.0	V	211.0	-14
158.559667	27.04	43.50	16.46	1000.0	1000.000	102.0	V	211.0	-14
649.128667	16.64	46.00	29.36	1000.0	1000.000	200.0	V	19.0	-13
737.482333	24.06	46.00	21.94	1000.0	1000.000	200.0	V	19.0	-13



2.2.9 FCC Part 15 B Class B Idle Mode 1GHz to 8GHz Results

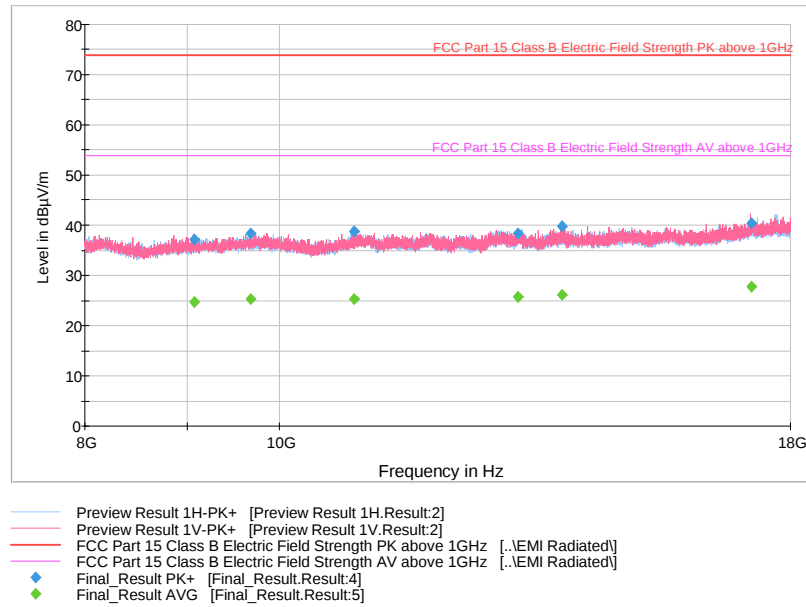


1GHz to 8GHz Test Data

Frequency (MHz)	Level (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
1089.067500	37.99	---	73.90	35.91	1000.0	1000.000	102.0	H	270.0
1089.067500	---	23.25	53.90	30.65	1000.0	1000.000	102.0	H	270.0
1610.760000	---	22.22	53.90	31.68	1000.0	1000.000	350.0	V	29.0
1610.760000	35.05	---	73.90	38.85	1000.0	1000.000	350.0	V	29.0
2823.044000	37.11	---	73.90	36.79	1000.0	1000.000	102.0	V	211.0
2823.044000	---	23.82	53.90	30.08	1000.0	1000.000	102.0	V	211.0
3322.158500	37.48	---	73.90	36.42	1000.0	1000.000	200.0	V	19.0
3322.158500	---	24.46	53.90	29.44	1000.0	1000.000	200.0	V	19.0
5485.720000	40.75	---	73.90	33.15	1000.0	1000.000	200.0	H	206.0
5485.720000	---	27.95	53.90	25.95	1000.0	1000.000	200.0	H	206.0
7846.186500	---	30.52	53.90	23.38	1000.0	1000.000	200.0	V	275.0
7846.186500	43.19	---	73.90	30.71	1000.0	1000.000	200.0	V	275.0
1089.067500	37.99	---	73.90	35.91	1000.0	1000.000	102.0	H	270.0
1089.067500	---	23.25	53.90	30.65	1000.0	1000.000	102.0	H	270.0



2.2.10 FCC Part 15 B Class B Battery Mode 8GHz to 18GHz Results



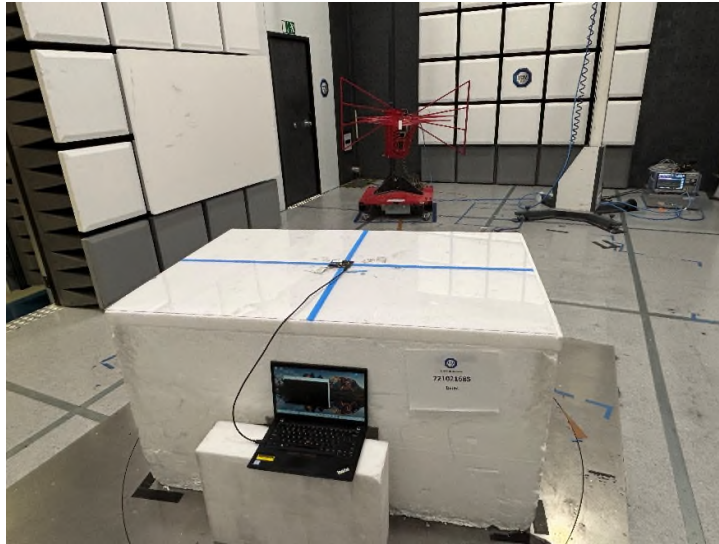
RSE 8GHz to 18GHz



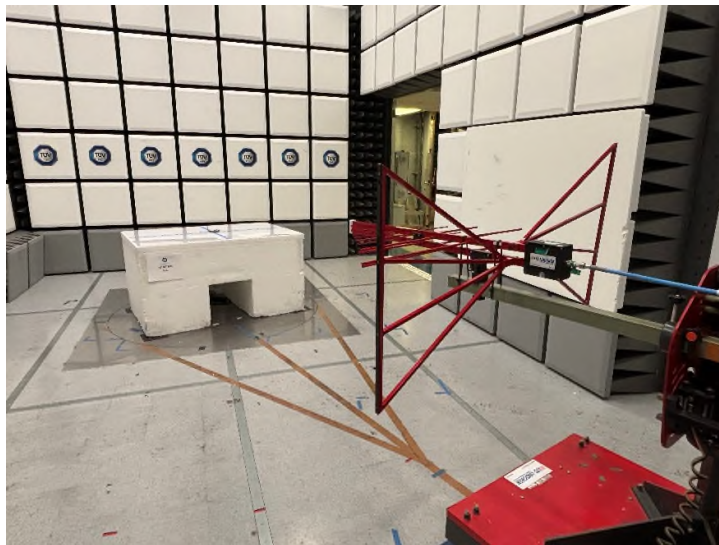
8GHz to 18GHz Test Data

Frequency (MHz)	Level (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
9074.298000	37.13	---	73.90	36.78	1000.0	1000.000	350.0	V	125.0
9074.298000	---	24.61	53.90	29.29	1000.0	1000.000	350.0	V	125.0
9680.897000	---	25.28	53.90	28.62	1000.0	1000.000	200.0	V	70.0
9680.897000	38.37	---	73.90	35.53	1000.0	1000.000	200.0	V	70.0
10906.856000	---	25.39	53.90	28.51	1000.0	1000.000	300.0	H	74.0
10906.856000	38.78	---	73.90	35.12	1000.0	1000.000	300.0	H	74.0
13163.942000	---	25.75	53.90	28.15	1000.0	1000.000	300.0	H	180.0
13163.942000	38.39	---	73.90	35.51	1000.0	1000.000	300.0	H	180.0
13848.418000	39.70	---	73.90	34.20	1000.0	1000.000	102.0	V	138.0
13848.418000	---	26.14	53.90	27.76	1000.0	1000.000	102.0	V	138.0
17217.560000	---	27.69	53.90	26.21	1000.0	1000.000	102.0	V	26.0
17217.560000	40.42	---	73.90	33.48	1000.0	1000.000	102.0	V	26.0
9074.298000	37.13	---	73.90	36.78	1000.0	1000.000	350.0	V	125.0
9074.298000	---	24.61	53.90	29.29	1000.0	1000.000	350.0	V	125.0

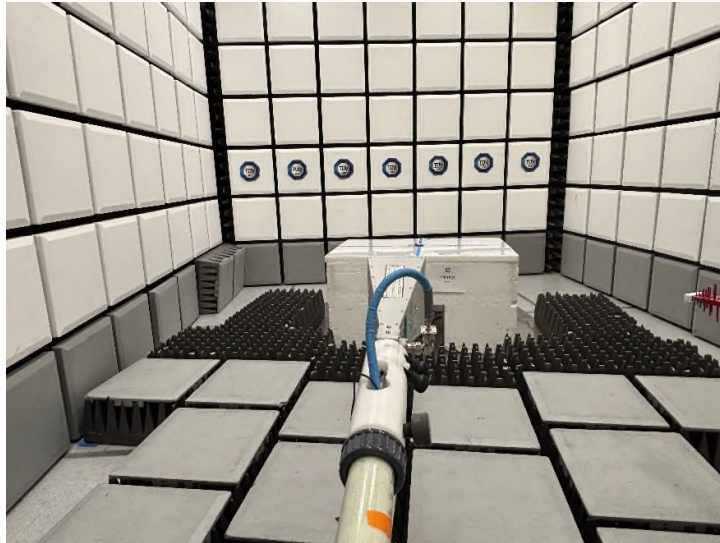
2.2.11 Test Setup photos



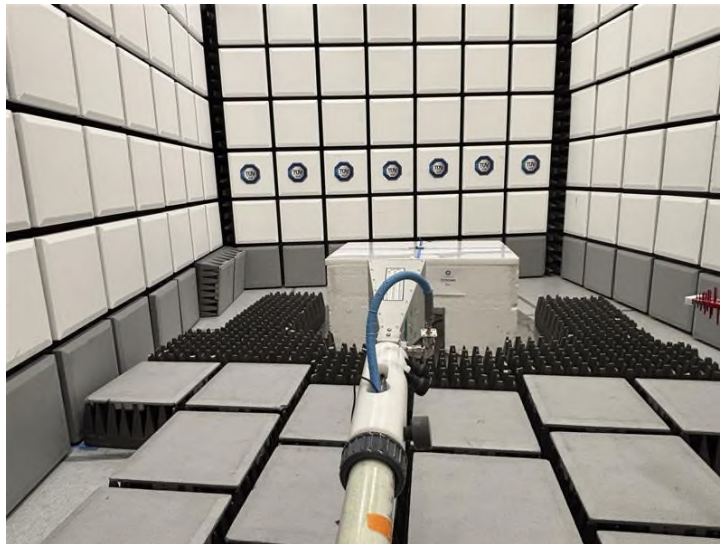
Radiated Emissions Idle Mode 30MHz to 1GHz Back



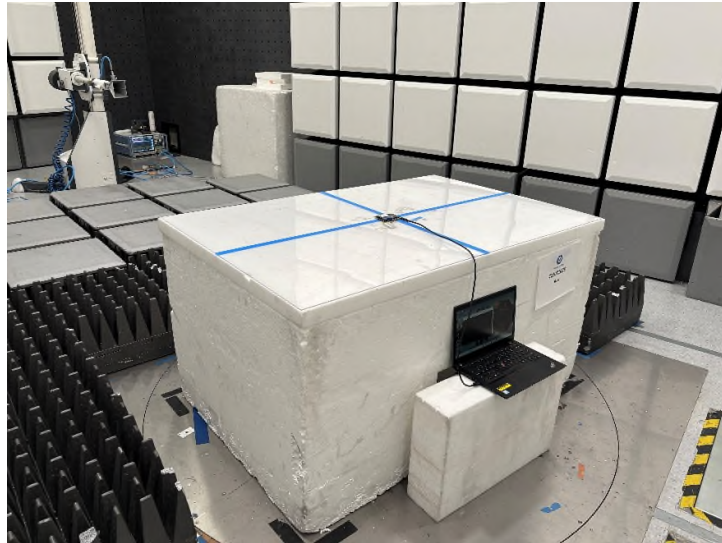
Radiated Emissions Idle Mode 30MHz to 1GHz Front



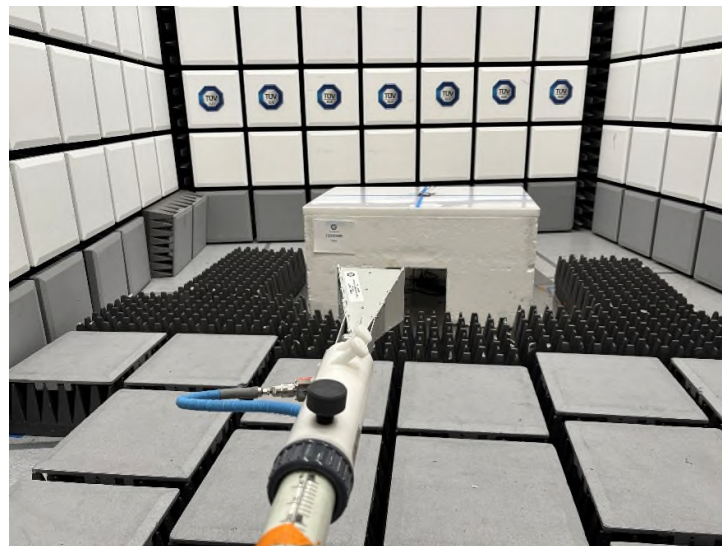
Radiated Emissions Idle Mode 1GHz to 8GHz Back



Radiated Emissions Idle Mode 1GHz to 8GHz Front



Radiated Emissions Idle Mode 8GHz to 18GHz Back



Radiated Emissions Battery Mode 8GHz to 18GHz Front



2.2.12 Test Location and Test Equipment Used

This test was carried out in the Mira Mesa Facility (SR5)

Instrument	Manufacturer	Type No	TE No	Calibration Period (Months)
BiConiLog Antenna	ETS Lindgren	3142C	31446	12
7.5-18 GHz Double Ridge Horn Antenna	Schwarzbeck Mess-Elektronik	HWRD 750	69562	12
1-10GHz Broad-Band Horn Antenna	Schwarzbeck Mess-Elektronik	BBHA 9120 B	69563	12
TUVSSU 010 PLC US	TUV SUD UK	TUVSSU 010 PLC US	74136	12
18-26GHz Antenna	Custom Microwave, Inc.	HO42S	30572	12
ESW44 EMI Test Receiver	Rohde & Schwarz	ESW44	68302	12
7GHz to 18GHz PreAmp	Ciao Wireless	CA718-403015N-FM	78961	12

Table 6



3 Test Equipment Information

3.1 General Test Equipment Used

Miscellaneous					
30215	Temp, Humidity and Barometric Sensor	iBTHX-W	15050268	Omega	05-22-2026
N/A	EMX Test Software	N/A	N/A	TUV SUD UK	N/A

Table 7



Product Service

4 Incident Reports

No incidents reports were raised.

5 Photographs

5.1 Equipment Under Test (EUT)





6 Measurement Uncertainty

For a 95% confidence level, the measurement uncertainties for defined systems are:

Test Name	Measurement Uncertainty
Conducted Disturbance at Mains Terminals	150 kHz to 30 MHz, LISN, ± 3.7 dB
Radiated Disturbance	30 MHz to 1 GHz, Bilog Antenna, ± 5.2 dB 1 GHz to 40 GHz, Horn Antenna, ± 6.3 dB

Table 8

Worst case error for both Time and Frequency measurement 12 parts in 10^6 .

*In accordance with CISPR 16